Study of the Atomic Structure and Phase Separation in Amorphous Si-C-N Ceramics by X-Ray and Neutron Diffraction

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Amorphous Si₃₇C₃₂N₃₁ and Si₃₇C₂₉N₃₄ ceramics were produced by pyrolysis of a polyhydromethylsilazane precursor. Their structure was investigated by X-ray and neutron diffraction. Wide angle diffraction showed that the Si-atoms are preferentially bonded to nitrogen atoms, but also bonding to carbon atoms was found. This suggests that the excess carbon atoms form an amorphous graphite-like phase. Small angle scattering revealed that the ceramics are inhomogeneous. The evolution of the phase separation during annealing was investigated and it was concluded that amorphous Si₃₇N₄₃ precipitates grow in the Si-C-N materials. The results are compared with previous results for amorphous Si₂₃C₄₃N₃₃ produced from a polysilylcarbodiimide precursor [1-3].

1. Introduction

Various questions about the structure of precursor derived amorphous Si-C-N ceramics are of importance, such as i) how does the structure depend on the way how it was produced from a polymer, ii) how does the structure change during further heat treatment up to the crystallization process, and iii) how does the structure of an amorphous alloy correlate with its composition, i.e. its location in the ternary Si-C-N phase diagram.

In the present work these question were addressed during an investigation of the structure of the amorphous ceramics Si₃₇C₃₂N₃₁ and Si₃₇C₂₉N₃₄, which were obtained by pyrolysis of a commercial polyhydromethylsilazane (NCP 200).

The X-ray diffraction diagram of an Si₃₇C₃₂N₃₁ sample in Fig. 1 shows that we have to distinguish between two overlapping scattering regimes: the wide angle scattering regime at 2Θ > 5°, which contains the information about the atomic short range order, and the small angle scattering regime at 2Θ < 5°, which is determined by inhomogeneities. The appearance of a strong small angle scattering effect reveals that the amorphous material is not homogeneous. In the present work, both scattering regimes were investigated in order to establish a detailed picture of the structure of amorphous Si-C-N ceramics.

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where \( q = 4\pi (\sin \Theta)/\lambda \) is the wave vector transfer, 
\( 2\Theta \) the scattering angle and \( \lambda \) the wave length. The 
brackets \( \langle \ \rangle \) denote compositional averages of the 
scattering lengths \( b_i \) of the atomic species \( i \), with 
atom fractions \( c_i \).

The total pair correlation function \( G(r) \) is obtained 
by Fourier transformation of the structure factor
\[
G(r) = \frac{2}{\pi} \int_0^\infty q [S(q) - 1] \sin(qr) dq. \tag{2}
\]

The total \( G(r) \) function is a weighted sum of the 
partial pair correlation functions \( G_{ij}(r) \):
\[
G(r) = \sum_{i=1}^{n} \sum_{j=1}^{n} \frac{c_i c_j b_i b_j}{\langle b_i \rangle^2} G_{ij}(r)
= \sum_{i=1}^{n} \sum_{j=1}^{n} W_{ij} G_{ij}(r). \tag{3}
\]

In case of a ternary system \((n = 3)\) we need 6 
partial \( G_{ij}(r) \) functions for the structural description 
of the system (note that \( G_{ij}(r) = G_{ji}(r) \)).

The partial pair density distribution function
\[
\rho_{ij}(r) = c_j \left( \rho_0 + \frac{G_{ij}(r)}{4\pi r} \right), \tag{4}
\]
where \( \rho_0 \) is the mean atomic number density, de-
scribes the number of \( j \)-type atoms per unit volume 
at distance \( r \) from an \( i \)-type atom at \( r = 0 \).

2.2. Inhomogeneous Structure and Small Angle 
Scattering

If the system is not homogeneous, but contains 
fluctuations of the composition and/or density on a 
medium range scale beyond the scale of atomic dis-
tances, say beyond 10 Å, a small angle scattering 
effect may be observed [6 - 8].

In case of the separation of a phase \( p \) in a matrix \( m \), 
the integrated intensity \( Q \), the so called invariant, is
\[
Q = \int I(q) q^2 dq = 2\pi^2 (\Delta \eta)^2 v(1 - v), \tag{5}
\]
where \( v \) is the volume fraction of the phase \( p \) and \( \Delta \eta 
= \eta_m - \eta_p \) is the difference of the scattering length 
densities of \( p \) and \( m \).

The mean scattering length density \( \langle \eta \rangle \) of 
the sample can be calculated from its composition and 
density:
\[
\langle \eta \rangle = \rho_0 \sum_{i=1}^{n} c_i b_i. \tag{6}
\]

On the other side, for a phase separated sample, \( \langle \eta \rangle \) is
\[
\langle \eta \rangle = (1 - v)\eta_m + v\eta_p. \tag{7}
\]
From (5) and (7) follows
\[
v = \sqrt{1 + 2\pi^2 (\eta_p - \langle \eta \rangle)^2 / Q^{-1}.} \tag{8}
\]

3. Experimental

3.1. Specimen Preparation

The amorphous Si-C-N ceramics were produced 
by pyrolysis of a polyhydromethylsilazane polymer 
\((NCP 200, \text{Chisso Corporation Japan})\). Two different 
routines were employed: The material investigated in 
the wide angle experiments was directly pyrolyzed at 
1050 °C in an argon atmosphere without crosslinking 
and densification. The heat treatment yielded amor-
phous \( \text{Si}_3\text{C}_2\text{N}_3 \) ceramics. The small angle scat-
tering experiments were performed with a batch of 
samples which have been prepared using the con-
ventional procedures, i.e. crosslinking, ball milling, 
green body pressing and pyrolysis at 1050 °C as 
described in [9]. Chemical analysis yielded the com-
position \( \text{Si}_{37}\text{C}_{29}\text{N}_{34} \) and an oxygen contamination of

![Fig. 2. Si-C-N phase diagram, showing the position of the Si-C-N samples with respect to the quasibinary lines Si3N4 - C and Si3N4 - SiC. 1: Si37C22N31, present work, 2: Si40C24N36 [10], 3: Si24C63N33 [1 - 3].](image)
about 2 at%. Thus we state that the two different preparation routines yielded almost the same composition. The compositions of the Si-C-N ceramics of the present work and of previous studies are shown in Fig. 2. The density of the ceramics was determined by mercury porosimetry measurements.

3.2. Diffraction Experiments

The X-ray wide angle scattering was measured up to \( q = 18 \, \text{Å}^{-1} \) in transmission mode using Ag-K\( \alpha \) radiation. The neutron wide angle scattering experiments were performed at the ISIS facility of the Rutherford Appleton Laboratory, UK, using the SANDALS instrument. With this instrument a range of the wave vector transfer up to \( q = 25 \, \text{Å}^{-1} \) could be measured with good counting statistics. This extended range of \( q \) is essential for the resolution of the individual atomic pairs \( i-j \) in \( r \)-space. Neutron small angle scattering was done at the BENSC facility of HMI, Berlin, using the V4 instrument.

4. Results and Discussion

4.1. Atomic Structure

The total structure factors, \( S_x(q) \) from X-ray scattering and \( S_n(q) \) from neutron scattering, are shown in Figure 3. The total pair correlation functions \( G_x(r) \) and \( G_n(r) \), obtained by Fourier transformation of the structure factors, are shown in Figs. 4 a, b. It is evident that X-ray scattering and neutron scattering yields strongly different runs of the pair correlation functions. With X-rays two distinct peaks, at 1.73 and 2.98 Å, are observed in the range \( r < 3.5 \, \text{Å} \), whereas in the neutron \( G_n(r) \) there are four peaks, at 1.37, 1.74, 2.46 and 2.85 Å. On the basis of the atomic sizes of the involved atomic species and the weighting factors \( W_{ij} \) in Table 1 these peaks can be attributed to individual atomic pairs \( i-j \).

In the following discussion the pair correlation functions \( G(r) \) of \( \text{Si}_{37}\text{C}_{32}\text{N}_{31} \) will be compared with
the \( G_n(r) \) of \( \text{Si}_{24}\text{C}_{43}\text{N}_{33} \) from [1, 3], and also with the related crystalline phases \( \text{Si}_3\text{N}_4 \), SiC [12] and graphite [13] and diamond [14].

The peaks at 1.37 and 2.46 Å in the neutron \( G_n(r) \) belong to a C-C correlation. With X-rays they are not observed due to the much smaller weighting factor (cf. Table 1). In the study on \( \text{Si}_{24}\text{C}_{43}\text{N}_{33} \) [1, 3], the two peaks were interpreted as due to a separated amorphous graphite-like carbon phase in the ceramics. Note that the peak positions are in good agreement with the distances in graphite at 1.42 and 2.46 Å. Thus it may be concluded that also in the \( \text{Si}_{37}\text{C}_{32}\text{N}_{31} \) ceramics there is an amorphous graphite-like carbon phase. Since the C-C weighting factor for \( \text{Si}_{37}\text{C}_{32}\text{N}_{31} \) is smaller than that for \( \text{Si}_{24}\text{C}_{43}\text{N}_{33} \), it can be understood that the C-C peaks are less pronounced in the total \( G_n(r) \) of \( \text{Si}_{37}\text{C}_{32}\text{N}_{31} \).

The peak at 1.74 Å reflects the Si-N bonds. Its amplitude is somewhat larger for \( G_n(r) \) than for \( G_n(r) \) which is in line with the corresponding \( W_{ij} \). The peak at 2.85 Å in \( G_n(r) \) is attributed to an N-N correlation, and the peak at 2.98 Å in \( G_n(r) \) to an Si-Si correlation where, however, also underlying contributions from other correlations are supposed. The positions of the latter three peaks are in good agreement with the corresponding distances in crystalline \( \text{Si}_3\text{N}_4 \) [11] (Si-N at 1.71...1.77 Å, N-N at 2.80...2.94 Å and Si-Si at 2.72...3.15 Å).

The comparison of the two \( G_n(r) \) functions in Fig. 4b shows that the peaks at 1.74 Å (Si-N) and 2.85 Å (N-N) in the \( G_n(r) \) of \( \text{Si}_{37}\text{C}_{32}\text{N}_{31} \) match well at their left flanks with the corresponding peaks at 1.74 and 2.81 Å in the \( G_n(r) \) of \( \text{Si}_{24}\text{C}_{43}\text{N}_{33} \). However, these peaks are broadened on their right hand sides, compared with the peaks of \( \text{Si}_{24}\text{C}_{43}\text{N}_{33} \), and the peak at 2.85 Å is shifted slightly to a larger \( r \) value. Since in crystalline SiC a direct Si-C distance appears at 1.89 Å and an indirect C-(Si)-C distance at 3.06 Å, this suggests that in amorphous \( \text{Si}_{37}\text{C}_{32}\text{N}_{31} \) there is also a considerable number of Si-C bonds, which causes the broadening at the right hand side of the peaks at 1.74 and 2.85 Å. Assuming that the peak at 1.74 Å in the \( G(r) \) of \( \text{Si}_{37}\text{C}_{32}\text{N}_{31} \) contains two contributions, namely a contribution of a Si-N correlation at about 1.74 Å and a contribution of a Si-C correlation at about 1.89 Å, the corresponding partial average coordination numbers \( Z_{ij} \) can be estimated from the peak areas \( A_{ij} \) using the relation

\[
Z_{ij} = \frac{c_j}{c_i} Z_{ji} = \frac{c_j}{W_{ij}} A_{ij}.
\]

The areas \( A_{ij} \) were determined by fitting two Gaussian curves to the peak of the corresponding total radial distribution function

\[
\text{RDF}(r) = 4\pi r^2 \rho_0 + r G(r),
\]

as shown in Figure 5. From the Gaussian at 1.74 Å, the average values \( Z_{\text{SiN}} = 3.0 \) and \( Z_{\text{NSi}} = 3.6 \), and from the Gaussian at 1.83 Å, the values \( Z_{\text{SiC}} = 1.0 \) and \( Z_{\text{CSI}} = 1.2 \) were obtained. The sum \( Z_{\text{Si}} = Z_{\text{SiN}} + Z_{\text{SiC}} = 4.0 \) proves that the Si-atoms are tetrahedrally coordinated in the amorphous ceramics. It should be noted that we cannot distinguish on the basis of the average values of \( Z_{\text{SiN}} \) and \( Z_{\text{SiC}} \) between the existence of only \( \text{SiN}_4 \) and \( \text{SiC}_4 \) tetrahedra or the additional existence of C-N mixed tetrahedra \( \text{Si(CN)}_4 \). The average number \( Z_{\text{NSi}} \) of 3.6 silicon atoms surrounding each nitrogen atom is fairly close to the three-fold coordination of nitrogen in crystalline \( \text{Si}_3\text{N}_4 \).

The wide angle scattering results suggest that within the \( \text{Si}_{37}\text{C}_{32}\text{N}_{31} \) ceramics the nitrogen atoms prefer a three fold silicon coordination in order to form an \( \text{Si}_3\text{N}_4 \)-like structure. The excess silicon bonds are saturated by carbon atoms and the excess carbon forms an amorphous phase of graphite-like carbon. The assumption of non-existing mixed \( \text{Si(CN)}_4 \)
tetrahedra corresponds to the formal subdivision of the Si$_{37}$C$_{29}$N$_{34}$ ceramics into 54 at\% Si$_3$N$_4$ + 28 at\% SiC + 18 at\% C. In the phase diagram of Fig. 2 this ceramics lies in the region between the lines of the two quasi-binary systems Si$_3$N$_4$ - C and Si$_3$N$_4$ - SiC. On the other hand, the Si$_{24}$C$_{43}$N$_{33}$ ceramics, where phase separation into Si$_3$N$_4$ + C and no indication for Si-C bonds was found [1 - 3], lies on the line of the quasi-binary system Si$_3$N$_4$ - C.

In a previous study on NCP 200-derived Si-C-N ceramics [10] it was not possible to obtain information about the environment of the C-atoms. This is probably due to the less extended $q$-range measured in [10], i.e. to lower resolution in real-space.

4.2. Phase Separation

Figure 6 shows the small angle neutron scattering (SANS) cross sections of amorphous Si$_{37}$C$_{29}$N$_{34}$ after annealing at 1300 °C. It is obvious that the material contains inhomogeneities which give rise to the observed SANS signal.

The SANS curves exhibit two regimes which are caused by different phenomena: Towards very small $q$ values the scattered intensities show a linear increase in the log-log plot. This effect is caused by scattering from the surface of pores in the material according to Porod's law [6 - 8] and was subtracted in the further data evaluation.

At larger $q$ values, a second scattering effect follows which exhibits a peak. This SANS effect depends strongly on the temperature and on the time of annealing. Annealing causes an increase of the intensity and also a shift of the peak towards lower $q$ values, which shows that the size of the scattering regions is growing. The occurrence of a peak indicates an interference effect, which means a substantial volume of distance-correlated regions within the material.

In the following a model for the phase separation of Si$_{37}$C$_{29}$N$_{34}$ is proposed which yields a quantitative description of the experimental SANS curves. In Table 2 the relevant parameters of different phases are listed which have to be considered as conceivable scattering regions. The contrast, i.e. the squared difference $(\Delta \eta)^2$ between the scattering length densities of the regions and the Si-C-N matrix is listed as a measure for the visibility of a certain type of regions in the SANS experiments. It should be noted that the regions, whatever their type, are still amorphous, because wide angle scattering did not indicate any traces of crystalline peaks up to 1400 °C. During crystallization of the Si-C-N ceramics at temperatures above 1400 °C the crystalline phases Si$_3$N$_4$ and SiC occur.

The values for $(\Delta \eta)^2$ in Table 2 are given for the case of a small volume fraction $\nu$ of the segregated phase, i.e. for a negligible change of the composition of the Si-C-N matrix. However, in case of a substantial amount of segregated Si$_3$N$_4$, the scattering length density of the remaining matrix changes considerably, and thus the contrast between the precipitates and the matrix increases. Figure 7 shows the variation of the contrast $(\Delta \eta)^2$, where the change of the matrix with increasing volume fraction $\nu$ of segregated Si$_3$N$_4$ is taken into account according to (7). The upper curve
shows the contrast between \( \text{Si}_3\text{N}_4 \) and the changing Si-C-N matrix. The lower curve shows the contrast between SiC precipitates and the Si-C-N matrix which remains after the segregation of an amount \( v \) of \( \text{Si}_3\text{N}_4 \). We note that the segregation of SiC would not change the scattering length density of the starting matrix because both, SiC and the matrix, have almost the same values of \( \eta \). In conclusion of this part of the discussion we state that the values of \( \Delta \eta \) in Table 2 and Fig. 7 reveal that the measured SANS effect has to be attributed to an amorphous \( \text{Si}_3\text{N}_4 \) phase, segregated in the Si-C-N matrix. Segregated SiC or carbon would not yield a contrast sufficient for the measured SANS signals.

The experimental SANS intensities were fitted by a hard-sphere model [6 - 8] for the \( \text{Si}_3\text{N}_4 \)-scattering regions as shown in Fig. 6 for the as-prepared sample:

\[
I_{\text{mod}}(q) = S_{\text{cor}}(q) \cdot I_{\text{hs}}(q).
\]

\( I_{\text{hs}}(q) \) is the scattering from a system of isolated hard spheres, and the structure factor \( S_{\text{cor}}(q) \) describes the interference effect due to the positional correlations between the hard spheres. From the fit, the average radius \( R \) of the regions and the invariant \( Q \) of the scattering were obtained. From the invariant, the volume fraction \( v \) of the segregated \( \text{Si}_3\text{N}_4 \) phase was calculated using (8) which takes into account the change of the matrix composition due to increasing \( v \).

Figure 8a shows the increase of the volume fraction \( v \) of the \( \text{Si}_3\text{N}_4 \) phase during the anneals of the ceramics. The dashed lines were fitted using a Gibbs-Evetts-Leake type of annealing function [15]. In the temperature range from 1050 up to 1300 °C the increase is faster at higher temperatures, and at 1400 °C the increase is again less steep. We note that the state of equilibrium, i.e. a saturation of the level of \( v \), is not attained within the time interval of 15 hrs. At 1450 °C the situation changes drastically. We observe a decrease of \( v \), which is explained by the decomposition of the segregated \( \text{Si}_3\text{N}_4 \) phase according to \( \text{Si}_3\text{N}_4 + 3 \text{C} \rightarrow 3 \text{SiC} + 2 \text{N}_2 \) [9].

The temperature-time dependence of the radius \( R \) of the scattering regions in Fig. 8b shows an increase from 12 Å in the as-prepared Si-C-N ceramics up
to about 25 Å after a 15 h anneal at 1400 °C. We note that the decrease of $\nu$ at 1450 °C in Fig. 8a is not associated with a decrease of $R$. This behaviour is explained by the facts that on the one hand the decomposition affects first the smaller Si$_3$N$_4$ regions, whereas on the other hand the size $R$, as established from small angle scattering, is associated mainly with the larger regions.

Concluding the SANS results it should be reminded that the separation of a graphite-like carbon phase in Si-C-N, besides the separation of a Si$_3$N$_4$ phase, as suggested from wide angle scattering, cannot be probed by SANS. This illustrates the importance of a combination of both scattering regimes in an investigation of amorphous ceramics. With future small angle X-ray scattering experiments we expect a contrast between the carbon phase and the Si-C-N matrix.

5. Conclusions

Amorphous Si-C-N ceramics were produced by pyrolysis of a polyhydromethylsilizane precursor and investigated by X-ray and neutron diffraction. The Si-atoms prefer tetrahedral bonding to nitrogen atoms, which leads to an inhomogeneous structure with amorphous Si$_3$N$_4$ precipitates. However, also Si - C bonds exist in the ceramics. The excess C-atoms form graphite-like amorphous carbon.

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